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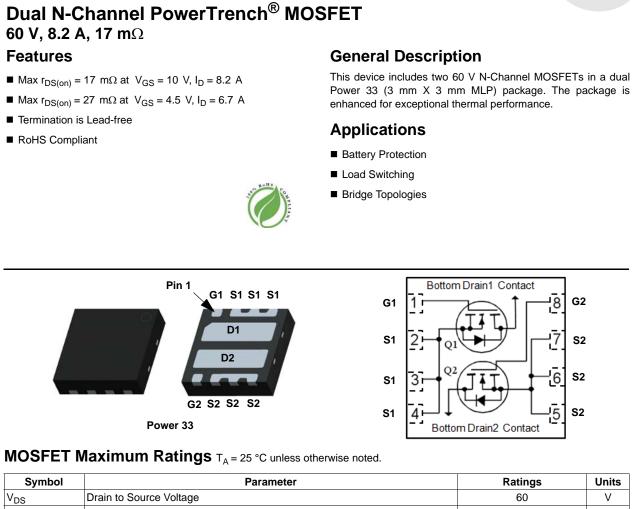


# **ON Semiconductor**®

# To learn more about ON Semiconductor, please visit our website at <u>www.onsemi.com</u>

Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (\_), the underscore (\_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (\_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at <a href="mailto:www.onsemi.com">www.onsemi.com</a>. Please email any questions regarding the system integration to <a href="mailto:Fairchild\_questions@onsemi.com">Fairchild\_questions@onsemi.com</a>.

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Symbol	Para	meter		Ratings	Units
V <sub>DS</sub>	Drain to Source Voltage			60	V
V <sub>GS</sub>	Gate to Source Voltage			±20	V
	Drain Current -Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	8.2	A
D	-Pulsed			40	A
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	32	mJ
D	Power Dissipation	T <sub>C</sub> = 25 °C		16	W
PD	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	1.9	vv
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Tempe	erature Range		-55 to +150	°C

#### **Thermal Characteristics**

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	8.0	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient (Note 1	a) 65	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient (Note 1	b) 155	

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC89521L	FDMC89521L	Power 33	13 "	12 mm	3000 units

August 2016



**FDMC89521L** 

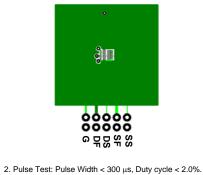
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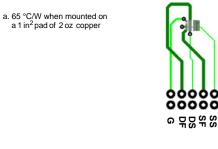
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Chara	octeristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_{D} = 250 \ \mu A, V_{GS} = 0 \ V$	60			V
$\Delta BV_{DSS}$ $\Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		30		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V			1	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20 V, V_{DS} = 0 V$			±100	nA
On Chara	cteristics				·	
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \ \mu A$	1	1.9	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		-6		mV/°C
r <sub>DS(on)</sub>		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8.2 A		13	17	
	Static Drain to Source On Resistance	$V_{GS} = 4.5 V, I_{D} = 6.7 A$		21 27		mΩ
		$V_{GS} = 10 V, I_D = 8.2 A, T_J = 125 °C$		20	26	- 1115.2
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 8.2 A		28		S
-	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 30 V, V_{GS} = 0 V,$		1228	1635	pF
C <sub>oss</sub>	Output Capacitance	f = 1 MHz		243	325	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			10	15	pF
R <sub>g</sub>	Gate Resistance			0.7		Ω
Switching	g Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time			7.9	16	ns
t <sub>r</sub>	Rise Time	$V_{DD}$ = 30 V, I <sub>D</sub> = 8.2 A, V <sub>GS</sub> = 10 V, R <sub>GEN</sub> = 6 Ω		2.1	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			18	33	ns
t <sub>f</sub>	Fall Time			1.7	10	ns
Qg	Total Gate Charge	$V_{GS} = 0$ V to 10 V		17	24	nC
Qg	Total Gate Charge	$V_{GS} = 0 V \text{ to } 4.5 V V_{DD} = 30 V,$		7.9	12	nC
Q <sub>gs</sub>	Gate to Source Charge	I <sub>D</sub> = 8.2 A		3.8		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge			1.9		nC

V <sub>SD</sub>	Source-Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 8.2 A (Note 2)	0.85	1.3	V
	Source-Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.6 A (Note 2)	0.75	1.2	v
t <sub>rr</sub>	Reverse Recovery Time	I <sub>E</sub> = 8.2 A, di/dt = 100 A/μs	25	40	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$F = 0.2 \text{ A, u/ut} = 100 \text{ A/}\mu\text{s}$	11	20	nC

Notes:

1. R<sub>0JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.

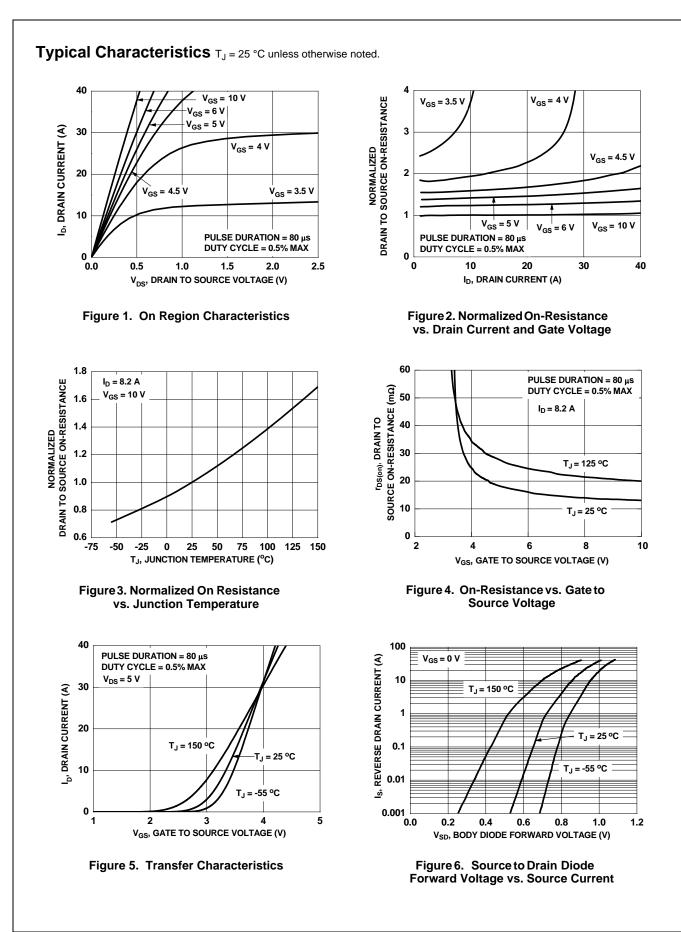




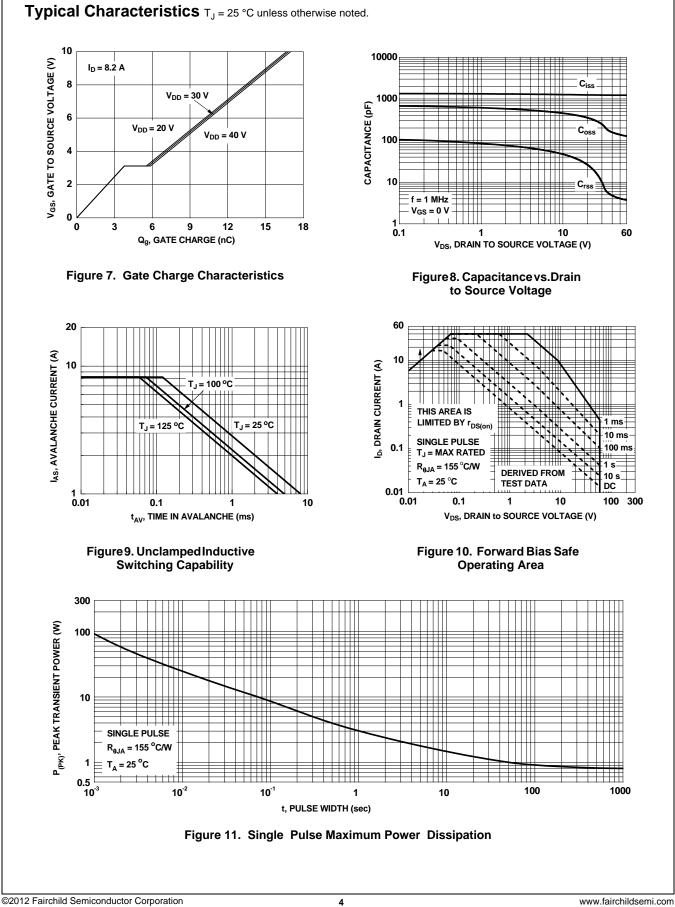
3. E<sub>AS</sub> of 32 mJ is based on starting T<sub>J</sub> = 25 °C, L = 1 mH, I<sub>AS</sub> = 8 A, V<sub>DD</sub> = 54 V, V<sub>GS</sub> = 10 V. 100% tested at L = 3 mH, I<sub>AS</sub> = 5.4 A.

b. 155 °C/W when mounted on a minimum pad of 2 oz copper

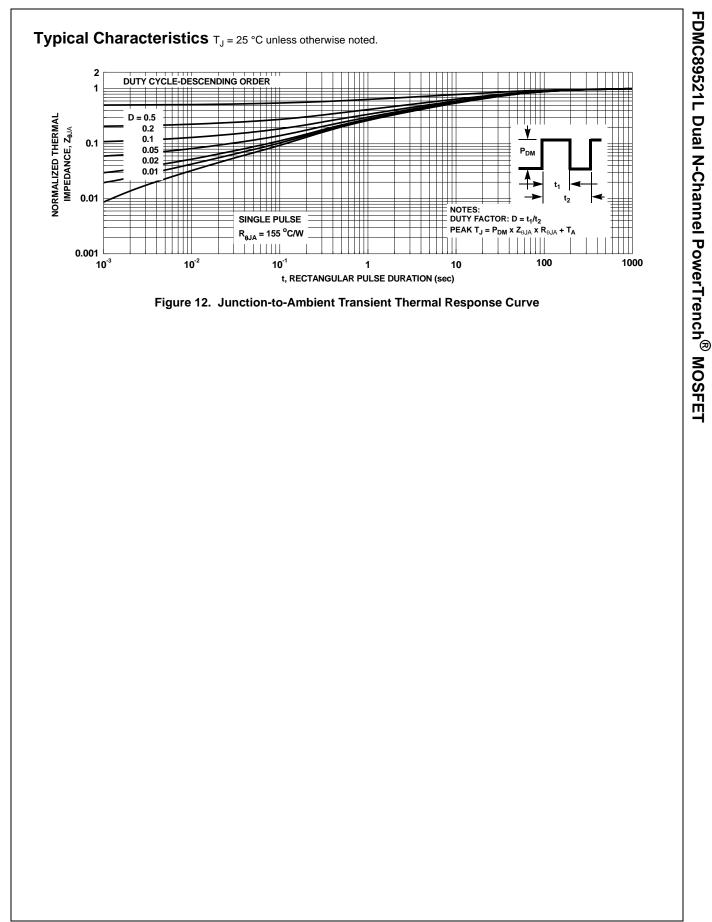
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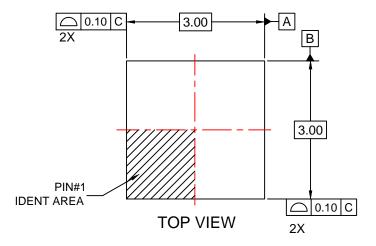


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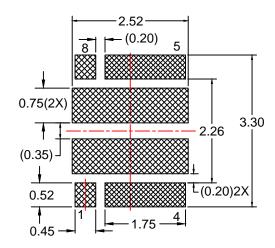




0.80 MAX

// 0.10 C

0.08 C

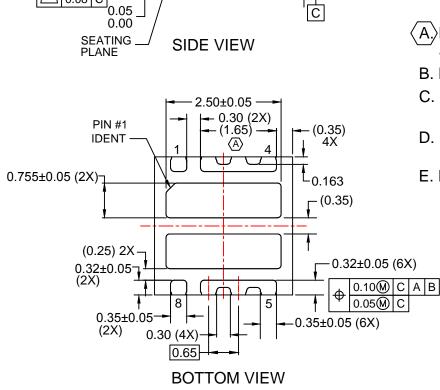


## RECOMMENDED LAND PATTERN

NOTES:

(0.20)

- A DOES NOT FULLY CONFORM TO JEDEC REGISTRATION, MO-229.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994
- D. LAND PATTERN RECOMMENDATION IS BASED ON FSC DESIGN ONLY
- E. DRAWING FILE NAME: MKT-MLP08Xrev2.



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